

# **MOSFET**

Metal Oxide Semiconductor Field Effect Transistor

# OptiMOS™ Power-Transistor, 100V

OptiMOS™3 Power-Transistor IPA086N10N3 G

# **Data Sheet**

Rev. 2.4 Final



# **OptiMOS**<sup>TM</sup>3 Power-Transistor

### **Features**

- N-channel, normal level
- Excellent gate charge x  $R_{\rm DS(on)}$  product (FOM)
- Very low on-resistance R<sub>DS(on)</sub>
- 175 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target application
- Ideal for high-frequency switching and synchronous rectification
- Halogen-free according to IEC61249-2-21
- Fully isolated package (2500 VAC; 1 minute)

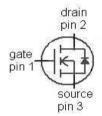
Туре	IPA086N10N3 G
	9
Package	PG-TO220-FP
Marking	086N10N

### **Product Summary**

$V_{ m DS}$	100	٧
$R_{\mathrm{DS(on),max}}$	8.6	mΩ
$I_{D}$	45	Α







**Maximum ratings,** at  $T_i$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I <sub>D</sub>	T <sub>C</sub> =25 °C <sup>2)</sup>	45	А
		T <sub>C</sub> =100 °C	32	
Pulsed drain current <sup>2)</sup>	I <sub>D,pulse</sub>	T <sub>C</sub> =25 °C	180	
Avalanche energy, single pulse	E <sub>AS</sub>	$I_{\rm D} = 45 \; {\rm A}, \; R_{\rm GS} = 25 \; {\rm \Omega}$	170	mJ
Gate source voltage	$V_{GS}$		±20	V
Power dissipation	$P_{\text{tot}}$	T <sub>C</sub> =25 °C	37.5	W
Operating and storage temperature	$T_{\rm j},~T_{\rm stg}$		-55 175	°C
IEC climatic category; DIN IEC 68-1			55/175/56	

<sup>1)</sup>J-STD20 and JESD22

<sup>&</sup>lt;sup>2)</sup> See figure 3



Parameter	Symbol	Conditions	Values		Unit	
			min.	typ.	max.	
Thermal characteristics						
Thermal resistance, junction - case	$R_{\mathrm{thJC}}$		-	-	4	K/W

# **Electrical characteristics,** at $T_j$ =25 °C, unless otherwise specified

### Static characteristics

Drain-source breakdown voltage	$V_{(BR)DSS}$	V <sub>GS</sub> =0 V, I <sub>D</sub> =1 mA	100	-	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS}=V_{\rm GS}, I_{\rm D}=75~\mu{\rm A}$	2	2.7	3.5	
Zero gate voltage drain current	I <sub>DSS</sub>	$V_{\rm DS} = 100 \text{ V}, V_{\rm GS} = 0 \text{ V}, $ $T_{\rm j} = 25 \text{ °C}$	-	0.1	1	μА
		$V_{\rm DS}$ =100 V, $V_{\rm GS}$ =0 V, $T_{\rm j}$ =125 °C	-	10	100	
Gate-source leakage current	I <sub>GSS</sub>	V <sub>GS</sub> =20 V, V <sub>DS</sub> =0 V	1	1	100	nA
Drain-source on-state resistance	$R_{\mathrm{DS(on)}}$	$V_{\rm GS}$ =10 V, $I_{\rm D}$ =45 A	1	7.5	8.6	mΩ
		$V_{\rm GS}$ =6 V, $I_{\rm D}$ =23 A	-	9.2	15.4	
Gate resistance	$R_{G}$		1	1.4	-	Ω
Transconductance	$g_{fs}$	$ V_{\rm DS}  > 2 I_{\rm D} R_{\rm DS(on)max},$ $I_{\rm D} = 45~{\rm A}$	35	69	-	S

 $<sup>^{3)}</sup>$  Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm $^{2}$  (one layer, 70  $\mu$ m thick) copper area for drain connection. PCB is vertical in still air.



Parameter	Symbol Conditions		Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	Ciss		-	2990	3980	рF
Output capacitance	Coss	$V_{GS}$ =0 V, $V_{DS}$ =50 V, $f$ =1 MHz	-	523	696	]
Reverse transfer capacitance	$C_{rss}$		-	21	-	
Turn-on delay time	$t_{d(on)}$		-	16	-	ns
Rise time	t <sub>r</sub>	V <sub>DD</sub> =50 V, V <sub>GS</sub> =10 V,	-	10	-	
Turn-off delay time	$t_{d(off)}$	$I_{\rm D}$ =45 A, $R_{\rm G,ext}$ =1.6 Ω	-	27	-	
Fall time	t <sub>f</sub>		-	8	-	
Gate Charge Characteristics <sup>4)</sup>					ı	
Gate to source charge	$Q_{gs}$		-	14	-	nC
Gate to drain charge	$Q_{gd}$		-	8	-	
Switching charge	$Q_{sw}$	$V_{\rm DD}$ =50 V, $I_{\rm D}$ =45 A, $V_{\rm GS}$ =0 to 10 V	-	13	-	
Gate charge total	$Q_{g}$		-	42	55	
Gate plateau voltage	$V_{ m plateau}$		-	4.6	-	٧
Output charge	$Q_{\rm oss}$	$V_{DD}$ =50 V, $V_{GS}$ =0 V	-	55	73	nC
Reverse Diode						
Diode continous forward current	Is	T -25 °C	-	-	45	Α
Diode pulse current	I <sub>S,pulse</sub>	- T <sub>C</sub> =25 °C	-	-	180	
Diode forward voltage	V <sub>SD</sub>	V <sub>GS</sub> =0 V, I <sub>F</sub> =45 A, T <sub>j</sub> =25 °C	-	0.9	1.2	V
Reverse recovery time	t <sub>rr</sub>	V <sub>R</sub> =50 V, I <sub>F</sub> =45 A,	-	63	-	ns
Reverse recovery charge	$Q_{\rm rr}$	d <i>i<sub>F</sub></i> /d <i>t</i> =100 A/μs	-	120	_	nC

<sup>&</sup>lt;sup>4)</sup> See figure 16 for gate charge parameter definition



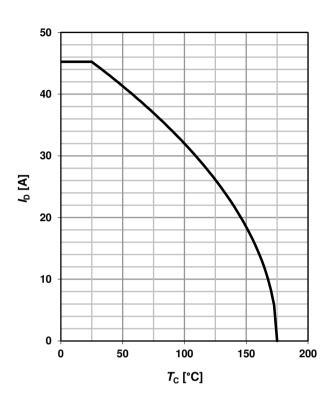
### 1 Power dissipation

# $P_{\text{tot}} = f(T_{\text{C}})$

# 40 35 30 25 $P_{\text{tot}}$ [W] 20 15 10 5 0 0 50 100 150 200 *T*<sub>C</sub> [°C]

### 2 Drain current

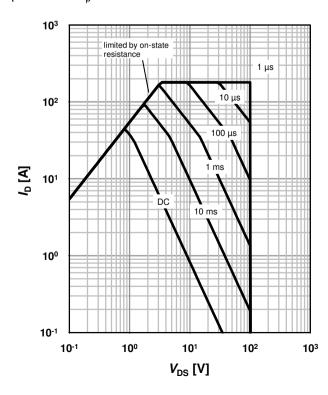
$$I_{D}=f(T_{C}); V_{GS}\geq 10 \text{ V}$$



# 3 Safe operating area

 $I_{D}=f(V_{DS}); T_{C}=25 \text{ °C}; D=0$ 

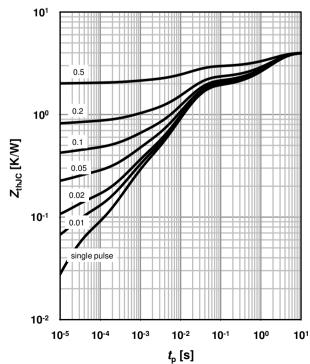
parameter: t<sub>p</sub>



### 4 Max. transient thermal impedance

 $Z_{\text{thJC}} = f(t_p)$ 

parameter:  $D=t_p/T$ 

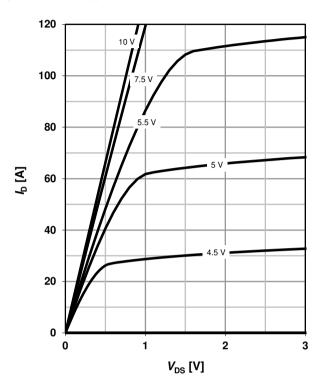




# 5 Typ. output characteristics

 $I_D=f(V_{DS}); T_i=25 \text{ °C}$ 

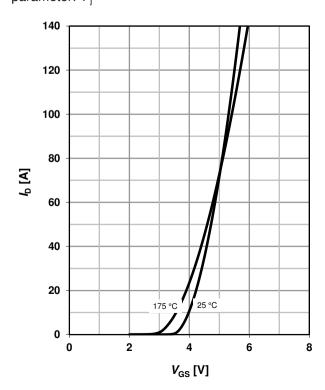
parameter:  $V_{\rm GS}$ 



# 7 Typ. transfer characteristics

 $I_{D}=f(V_{GS}); |V_{DS}|>2|I_{D}|R_{DS(on)max}$ 

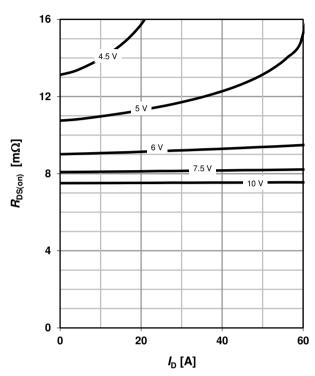
parameter: T<sub>i</sub>



# 6 Typ. drain-source on resistance

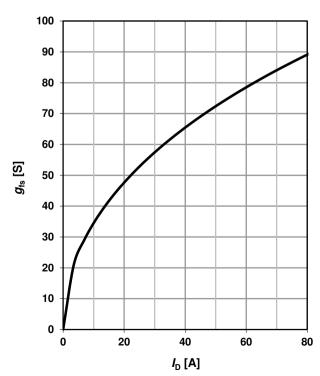
 $R_{DS(on)}=f(I_D); T_j=25 \text{ °C}$ 

parameter:  $V_{\rm GS}$ 



# 8 Typ. forward transconductance

$$g_{fs}$$
=f( $I_D$ );  $T_j$ =25 °C





# 9 Drain-source on-state resistance

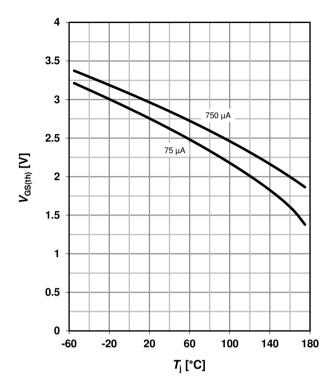
 $R_{DS(on)} = f(T_i); I_D = 45 \text{ A}; V_{GS} = 10 \text{ V}$ 

# 20 18 16 14 12 $R_{\mathrm{DS(on)}}$ [m $\Omega$ ] 98 % 10 8 6 4 2 -60 -20 20 60 100 140 180 *T*<sub>j</sub> [°C]

### 10 Typ. gate threshold voltage

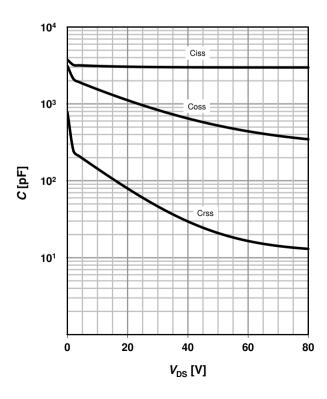
 $V_{GS(th)} = f(T_j); V_{GS} = V_{DS}$ 

parameter: I<sub>D</sub>



# 11 Typ. capacitances

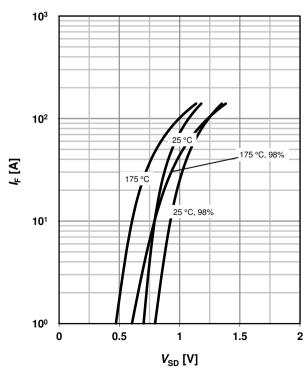
 $C=f(V_{DS}); V_{GS}=0 V; f=1 MHz$ 



### 12 Forward characteristics of reverse diode

 $I_{\mathsf{F}} = \mathsf{f}(V_{\mathsf{SD}})$ 

parameter: T<sub>i</sub>





### 13 Avalanche characteristics

 $I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$ 

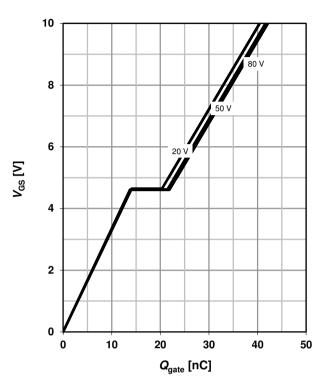
parameter:  $T_{j(start)}$ 

# 100 25 °C 100 °C 25 °C 100 °C 150 °C 100 °C 150 °C 1000 °C

# 14 Typ. gate charge

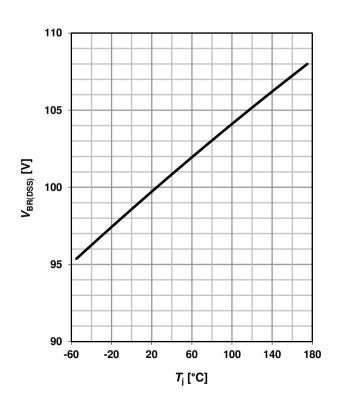
 $V_{GS}$ =f( $Q_{gate}$ );  $I_D$ =45 A pulsed

parameter:  $V_{\rm DD}$ 

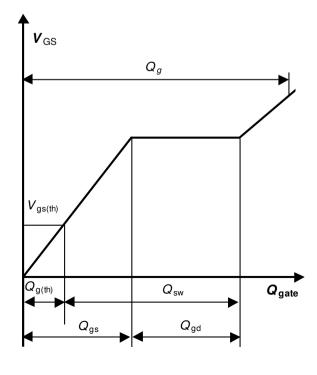


### 15 Drain-source breakdown voltage

 $V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$ 

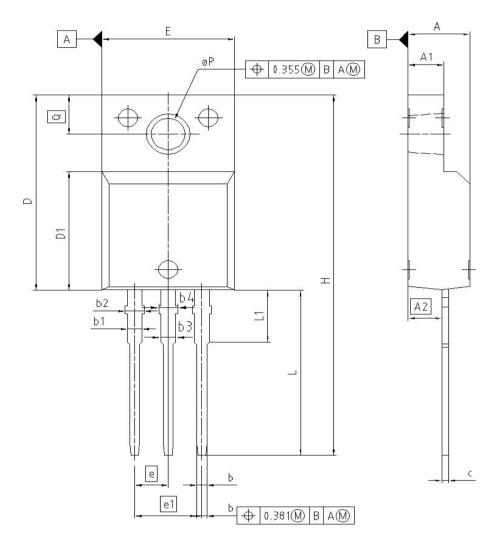


### 16 Gate charge waveforms





# PG-TO220-FP



BUIL	MILLIN	IETERS	INCI	HES
DIM	MIN	MAX	MIN	MAX
Α	4.55	4.85	0.179	0.191
A1	2.55	2.85	0.100	0.112
A2	2.42	2.72	0.095	0.107
b	0.65	0.85	0.026	0.033
b1	0.95	1.33	0.037	0.052
b2	0.95	1.51	0.037	0.059
b3	0.65	1.33	0.026	0.052
b4	0.65	1.51	0.026	0.059
C	0.40	0.63	0.016	0.025
D	15.85	16.15	0.624	0.636
D1	9.53	9.83	0.375	0.387
E	10.35	10.65	0.407	0.419
е	2.	54	0.1	100
e1	5.	08	0.2	200
N		3		3
н	29.45	29.75	1.159	1.171
L	13.45	13.75	0.530	0.541
L1	3.15	3.45	0.124	0.136
pΡ	2.95	3.20	0.116	0.126
Q	3.15	3.50	0.124	0.138

REFERE	NCE
SCALE	0
0 2.5 L	2.5 5mm
EUROPEAN PE	ROJECTION
I <b>SSUE</b> D 08-01-2	
FILE TO22	5





### **IPA086N10N3 G**

### **Revision History**

IPA086N10N3 G

Revision: 2015-08-27, Rev. 2.4

Previous Revision

1 10 110 00 11	CVIDIOII	
Revision	Date	Subjects (major changes since last revision)
2.4	2015-08-27	Update features: "Fully isolated package"

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10